


<p><i>Search Notes</i></p> 	Application/Control No. 10594842	Applicant(s)/Patent Under Reexamination MURAKAWA ET AL.
	Examiner Leigh Marie Garbowski	Art Unit 2825

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Google, IEEExplore, ACM Portal [all strategies as per IEEExplore attachment]	07/15/2008	LMG
WEST	07/16/2008	LMG
WEST (see search history printout)	02/20/2009	LMG
classes 703, 706, 716 (text search only - see search history printout)	02/20/2009	LMG

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
716	2, 4	02/20/2009	LMG
703	13	02/20/2009	LMG
706	13	02/20/2009	LMG

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